

501.43127X00

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s): C. SHISHIDO, et al

Serial No.: (not yet assigned)

Filed: October 7, 2003

For: A METHOD FOR MEASURING THREE-DIMENSIONAL SHAPE
OF A FINE PATTERN

PRELIMINARY AMENDMENT

Mail Stop Non-Fee Amendment
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

October 7, 2003

Sir:

The following amendments and remarks are respectfully submitted in
connection with the above-identified application, as listed below and as set forth on
the following pages:

Marked Up Specification and Substitute Specification;
Amendments to the Abstract;
Amendments to the Claims; and
Remarks are included following the amendments.